

<b>Notice of References Cited</b>	Application/Control No. 10/519,891	Applicant(s)/Patent Under Reexamination YAMAMIZU ET AL.	
	Examiner Megann E. Vaughn	Art Unit 2859	Page 1 of 1

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*	B	US-6,246,239	06-2001	Krogmann et al.	324/318
*	C	US-7,057,389	06-2006	Kamimura et al.	324/318
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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